INTEGRATED CIRCUITS

DATA SHEET

74ALVCH162827

20-bit buffer/line driver, non-inverting, with 30Ω termination resistors (3-State)

Product specification

1998 Sep 29

IC24 Data Handbook





20-bit buffer/line driver, non-inverting, with 30 Ω termination resistors (3-State)

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FEATURES

- Complies with JEDEC standard no. 8-1A.
- CMOS low power consumption
- Direct interface with TTL levels
- Current drive ± 12 mA at 3.0 V
- MULTIBYTETM flow-through standard pin-out architecture
- Low inductance multiple V_{CC} and GND pins for minimum noise and ground bounce
- Integrated 30 Ω termination resistors

DESCRIPTION

The 74ALVCH162827 high-performance CMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ALVCH162827 20-bit buffers provide high performance bus interface buffering for wide data/address paths or buses carrying parity. They have NAND Output Enables (nOE1, nOE2) for maximum control flexibility.

The 74ALVCH162827 is designed with 30Ω series resistance in both the pull-up and pull-down output structures. This design reduces line noise in applications such as memory address drivers, clock drivers and bus receivers/transmitters.

To ensure the high impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

QUICK REFERENCE DATA

GND = 0V; $T_{amb} = 25^{\circ}C$; $t_r = t_f = 2.5 \text{ns}$

SYMBOL	PARAMETER	CONDITION	CONDITIONS			
t _{PHL} /t _{PLH}	Propagation delay nAn to nYn	$V_{CC} = 2.5V, C_L = 30pF$ $V_{CC} = 3.3V, C_L = 50pF$	2.9 2.9	ns		
C _I	Input capacitance			5	pF	
C _{PD}	Power dissipation capacitance per latch	$V_1 = GND \text{ to } V_{CC}^1$	Output enabled	14	pF	
l Obp	l ower dissipation capacitance per laten	1 - 214D 10 ACC	Output disabled	3	Pi	

NOTES:

 C_{PD} is used to determine the dynamic power dissipation (P_D in μW): P_D = C_{PD} × V_{CC}² × f_i + Σ (C_L × V_{CC}² × f_o) where: f_i = input frequency in MHz; C_L = output load capacity in pF;

 f_0 = output frequency in MHz; V_{CC} = supply voltage in V;

 $\Sigma (C_L \times V_{CC}^2 \times f_0) = \text{sum of outputs.}$

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
56-Pin Plastic TSSOP Type II	-40°C to +85°C	74ALVCH162827DGG	ACH162827DGG	SOT364-1

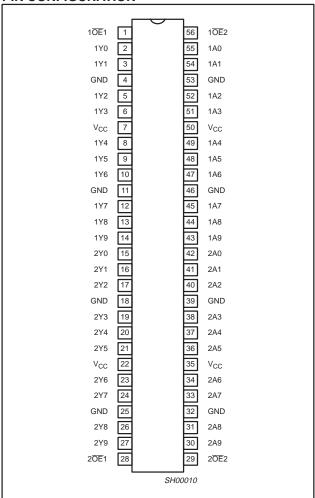
PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
55, 54, 52, 51, 49, 48, 47, 45, 44, 43, 42, 41, 40, 38, 37, 36, 34, 33, 31, 30	1A0 - 1A9 2A0 - 2A9	Data inputs
2, 3, 5, 6, 8, 9, 10, 12, 13, 14, 15, 16, 17, 19, 20, 21, 23, 24, 26, 27	1Y0 - 1Y9 2Y0 - 2Y9	Data outputs
1, 56, 28, 29	1 <u>0E</u> 1 1 <u>0E</u> 2, 2 <u>0E</u> 1, 2 <u>0E</u> 2	Output enable inputs (active-LOW)
4, 11, 18, 25, 32, 39, 46, 53	GND	Ground (0V)
7, 22, 35, 50	V _{CC}	Positive supply voltage

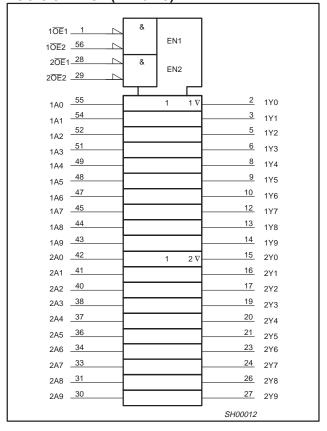
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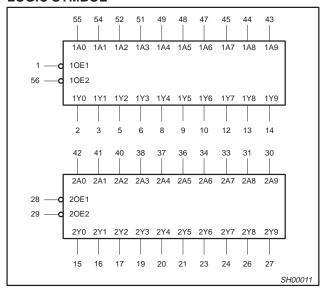
PIN CONFIGURATION



LOGIC SYMBOL (IEEE/IEC)



LOGIC SYMBOL



FUNCTION TABLE

	INPUTS		OUTPUT	OPERATING MODE
nOE1	nOE2	nAn	nYn	OI ENATING MODE
L	L	L	L	Transparent
L	L	Н	Н	Transparent
Н	Х	Х	Z	High impedance
Х	Н	Х	Z	High impedance

= Don't care

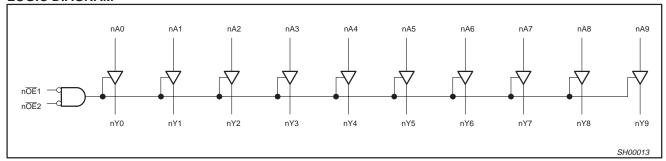
High impedance "off" state

High voltage level Low voltage level

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LOGIC DIAGRAM



RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
V	DC supply voltage 2.5V range (for max. speed performance @ 30 pF output load)		2.3	2.7	V
V _{CC}	DC supply voltage 3.3V range (for max. speed performance @ 50 pF output load)		3.0	3.6	V
VI	DC Input voltage range		0	V _{CC}	V
Vo	DC output voltage range		0	V _{CC}	V
T _{amb}	Operating free-air temperature range		-40	+85	°C
t _r , t _f	Input rise and fall times	$V_{CC} = 2.3 \text{ to } 3.0 \text{V}$ $V_{CC} = 3.0 \text{ to } 3.6 \text{V}$	0 0	20 10	ns/V

ABSOLUTE MAXIMUM RATINGS

In accordance with the Absolute Maximum Rating System (IEC 134) Voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current $V_1 < 0$		-50	mA
V _I	DC input voltage	Note 1	-0.5 to +4.6	V
I _{OK}	DC output diode current	$V_{O} > V_{CC}$ or $V_{O} < 0$	±50	mA
Vo	DC output voltage	Note 1	-0.5 to V _{CC} +0.5	V
Io	DC output source or sink current	$V_O = 0$ to V_{CC}	±50	mA
I _{GND} , I _{CC}	DC V _{CC} or GND current		±100	mA
T _{stg}	Storage temperature range		-65 to +150	°C
P _{TOT}	Power dissipation per package –plastic thin-medium-shrink (TSSOP)	For temperature range: –40 to +125 °C above +55°C derate linearly with 8 mW/K	600	mW

NOTE:

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^{1.} The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions. Voltage are referenced to GND (ground = 0 V).

				LIMITS		UNIT	
SYMBOL	PARAMETER	TEST CONDITIONS	Temp :	= -40°C to +8	5°C		
			MIN	TYP ¹	MAX	1	
		V _{CC} = 2.3 to 2.7V	1.7	1.2		.,	
V_{IH}	HIGH level Input voltage	V _{CC} = 2.7 to 3.6V	2.0	1.5		\ \	
.,	1000	V _{CC} = 2.3 to 2.7V		1.2	0.7	٠,,	
V_{IL}	LOW level Input voltage	V _{CC} = 2.7 to 3.6V		1.5	0.8	\ \	
		V_{CC} = 2.3 to 3.6V; V_I = V_{IH} or V_{IL} ; I_O = -100 μ A	V _{CC} -0.2	V _{CC}			
		$V_{CC} = 2.3V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -4mA$	V _{CC} _0.4	V _{CC} _0.11		1	
		$V_{CC} = 2.3V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -6$ mA	V _{CC} -0.6	V _{CC} -0.17		1	
V_{OH}	HIGH level output voltage	$V_{CC} = 2.7V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -4mA$	V _{CC} -0.5	V _{CC} -0.09		V	
		$V_{CC} = 2.7V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -8mA$	V _{CC} -0.7	V _{CC} -0.19		1	
		$V_{CC} = 3.0V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -6mA$	V _{CC} -0.6	V _{CC} -0.13		1	
		$V_{CC} = 3.0V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = -12mA$	V _{CC} -1.0	-1.0 V _{CC} -0.27		1	
		V_{CC} = 2.3 to 3.6V; V_I = V_{IH} or V_{IL} ; I_O = 100 μ A		GND	0.20		
		$V_{CC} = 2.3V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = 4mA$		0.07	0.40	1	
	LOW level output voltage	$V_{CC} = 2.3V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = 6mA$		0.11	0.55	1	
V_{OL}		$V_{CC} = 2.7V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = 4mA$		0.06	0.40	V	
		$V_{CC} = 2.7V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = 8mA$		0.13	0.60		
		$V_{CC} = 3.0V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = 6mA$	= 3.0V; $V_I = V_{IH}$ or $V_{IL;} I_O = 6mA$ 0.09				
		$V_{CC} = 3.0V$; $V_I = V_{IH}$ or V_{IL} ; $I_O = 12mA$		0.19	0.80	1	
II	Input leakage current	V_{CC} = 2.3 to 3.6V; V_I = V_{CC} or GND		0.1	5	μA	
I _{OZ}	3-State output OFF-state current	V_{CC} = 2.3 to 3.6V; V_I = V_{IH} or V_{IL} ; V_O = V_{CC} or GND		0.1	10	μA	
I _{CC}	Quiescent supply current	$V_{CC} = 2.3$ to 3.6V; $V_I = V_{CC}$ or GND; $I_O = 0$		0.2	40	μA	
ΔI_{CC}	Additional quiescent supply current	$V_{CC} = 2.3V$ to 3.6V; $V_I = V_{CC} - 0.6V$; $I_O = 0$		150	750	μA	
I _{BHL}	Bus hold LOW sustaining current	$V_{CC} = 2.3V; V_I = 0.7V^2$	45	-		μA	
	Bug hold HICH quataining current	$V_{CC} = 2.3V; V_I = 1.7V^2$	-45				
I _{ВНН}	Bus hold HIGH sustaining current	$V_{CC} = 3.0V; V_1 = 2.0V^2$	-75 - 175			μ/	
I _{BHLO}	Bus hold LOW overdrive current	$V_{CC} = 3.6V^2$	500			μA	
I _{BHHO}	Bus hold HIGH overdrive current	$V_{CC} = 3.6V^2$	-500			μA	

NOTES:

1. All typical values are at T_{amb} = 25°C.

2. Valid for data inputs of bus hold parts.

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AC CHARACTERISTICS FOR V_{CC} = 2.5V \pm 0.2V GND = 0V; t_r = t_f \leq 2.0ns; C_L = 30pF

SYMBOL	PARAMETER	WAVEFORM	V	UNIT		
			MIN	TYP ¹	MAX	
t _{PHL} /t _{PLH}	Propagation delay nAn to nYn	1, 3	1.0	2.9	4.6	ns
t _{PZH} /t _{PZL}	3-State output enable time nOEn to nYn	2, 3	1.4	3.9	6.4	ns
t _{PHZ} /t _{PLZ}	3-State output disable time nOEn to nYn	2,3	1.7	2.2	5.9	ns

NOTE:

AC CHARACTERISTICS FOR V_{CC} = 3.0V \pm 0.3V

 $GND = 0V; \ t_{\Gamma} = t_f \leq 2.5 ns; \ C_L = 50 pF$

	SYMBOL PARAMETER			LIMITS		LIM		
SYMBOL			٧٥	$_{\rm CC}$ = 3.3 \pm 0.3	3V	V _{CC} =	UNIT	
			MIN	TYP ^{1, 2}	MAX	TYP ¹	MAX	
t _{PHL} /t _{PLH}	Propagation delay nAn to nYn	1, 3	1.5	2.9	4.2	3.1	4.7	ns
t _{PZH} /t _{PZL}	3-State output enable time nOEn to nYn	2, 3	1.6	3.7	5.4	4.4	6.5	ns
t _{PHZ} /t _{PLZ}	3-State output disable time nOEn to nYn	2, 3	1.8	3.0	4.7	3.2	5.2	ns

^{1.} All typical values are at V_{CC} = 2.5V and T_{amb} = 25°C.

All typical values are at V_{CC} T_{amb} = 25°C.
 Typical value is measured at V_{CC} = 3.3V.

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AC WAVEFORMS FOR $V_{CC} = 2.3V$ TO 2.7V

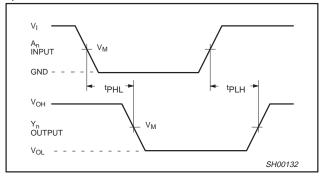
 $\begin{array}{l} V_M=0.5\ V_{CC} \\ V_X=V_{OL}+0.15V \\ V_Y=V_{OH}-0.15V \\ V_{OL} \ and \ V_{OH} \ are \ the \ typical \ output \ voltage \ drop \ that \ occur \ with \ the \ output \ load. \\ V_I=V_{CC} \end{array}$

AC WAVEFORMS FOR $V_{CC} = 3.0V$ TO 3.6V AND V_{CC} = 2.7V RANGE

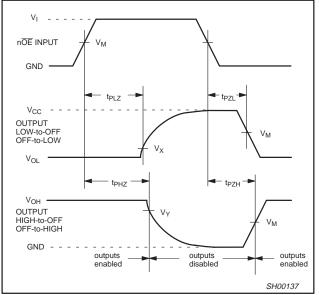
V_M = 1.5 V

 $V_{X} = V_{OL} + 0.3V$

 $V_{\rm Y} = V_{\rm OH} - 0.3V$ $V_{\rm OL}$ and $V_{\rm OH}$ are the typical output voltage drop that occur with the output load. $\frac{V_{I}}{I} = 2.7V$

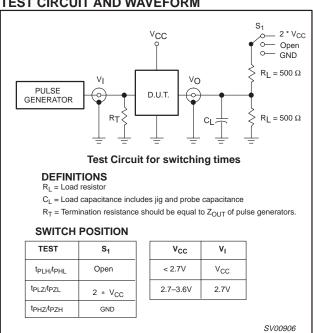


Waveform 1. Input (nAx) to Output (nYx) Propagation Delays



Waveform 2. 3-State Output Enable and Disable Times

TEST CIRCUIT AND WAVEFORM



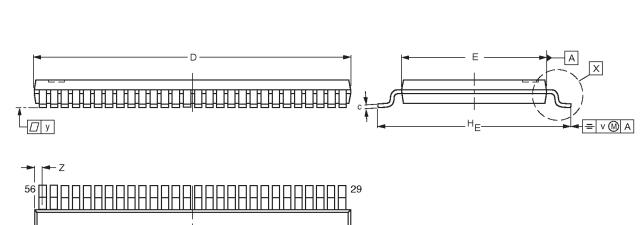
Waveform 3. Load circuitry for switching times

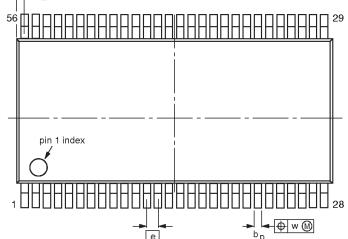
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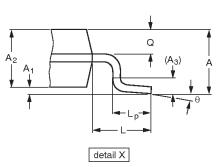
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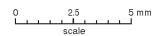
TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1mm

SOT364-1









DIMENSIONS (mm are the original dimensions).

						-,-												
UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	z	θ
mm	1.2	0.15 0.05	1.05 0.85	0.25	0.28 0.17	0.2 0.1	14.1 13.9	6.2 6.0	0.5	8.3 7.9	1.0	0.8 0.4	0.50 0.35	0.25	0.08	0.1	0.5 0.1	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE REFERENCES						EUROPEAN	ISSUE DATE	
VERSION IEC		JEDEC	EIAJ			PROJECTION	ISSUE DATE	
SOT364-1		MO-153EE					-93-02-03 95-02-10	

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NOTES

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Date of release: 06-98

Document order number:

9397-750-04603

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